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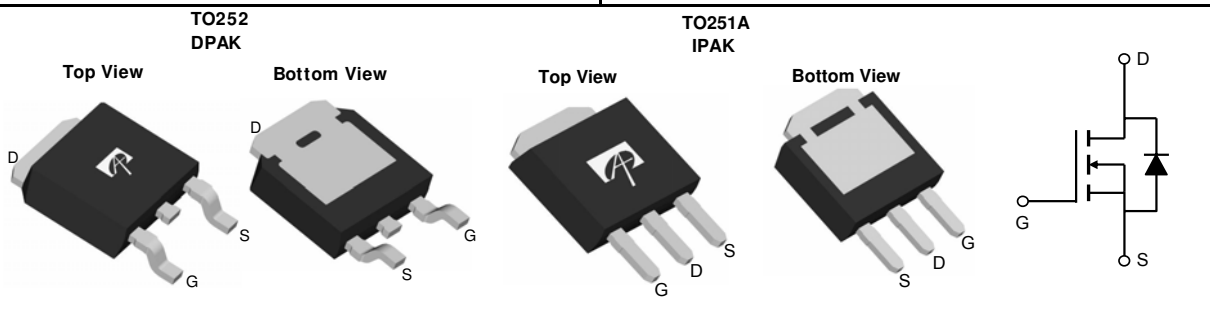
### General Description

The AOD418/AOI418 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and low gate resistance. With the excellent thermal resistance of the DPAK/IPAK package, this device is well suited for high current load applications.

### Product Summary

|                                  |                 |
|----------------------------------|-----------------|
| $V_{DS}$                         | 30V             |
| $I_D$ (at $V_{GS}=10V$ )         | 36A             |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ )  | < 7.5m $\Omega$ |
| $R_{DS(ON)}$ (at $V_{GS}=4.5V$ ) | < 11m $\Omega$  |

100% UIS Tested  
 100%  $R_g$  Tested



### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter                                      | Symbol           | Maximum                 | Units            |
|--|------------------|-------------------------|------------------|
| Drain-Source Voltage                           | $V_{DS}$         | 30                      | V                |
| Gate-Source Voltage                            | $V_{GS}$         | $\pm 20$                | V                |
| Continuous Drain Current <sup>G</sup>          | $I_D$            | $T_C=25^\circ\text{C}$  | 36               |
|  |                  | $T_C=100^\circ\text{C}$ | 28               |
| Pulsed Drain Current <sup>C</sup>              | $I_{DM}$         | 125                     | A                |
| Continuous Drain Current                       | $I_{DSM}$        | $T_A=25^\circ\text{C}$  | 13.5             |
|  |                  | $T_A=70^\circ\text{C}$  | 10.5             |
| Avalanche Current <sup>C</sup>                 | $I_{AS}, I_{AR}$ | 27                      | A                |
| Avalanche energy $L=0.1\text{mH}$ <sup>C</sup> | $E_{AS}, E_{AR}$ | 36                      | mJ               |
| Power Dissipation <sup>B</sup>                 | $P_D$            | $T_C=25^\circ\text{C}$  | 50               |
|  |                  | $T_C=100^\circ\text{C}$ | 25               |
| Power Dissipation <sup>A</sup>                 | $P_{DSM}$        | $T_A=25^\circ\text{C}$  | 2.5              |
|  |                  | $T_A=70^\circ\text{C}$  | 1.6              |
| Junction and Storage Temperature Range         | $T_J, T_{STG}$   | -55 to 175              | $^\circ\text{C}$ |

### Thermal Characteristics

| Parameter                                  | Symbol          | Typ          | Max | Units                     |
|--|-----------------|--------------|-----|---------------------------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 16           | 20  | $^\circ\text{C}/\text{W}$ |
| Maximum Junction-to-Ambient <sup>A,D</sup> |                 | Steady-State | 41  | 50                        |
| Maximum Junction-to-Case                   | $R_{\theta JC}$ | 2.5          | 3   | $^\circ\text{C}/\text{W}$ |

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter  | Conditions   | Min  | Typ        | Max         | Units |
|-----------------------------|--|--|------|------------|-------------|-------|
| <b>STATIC PARAMETERS</b>    |  |  |      |            |             |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage                     | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V   | 30   |            |             | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current                    | V <sub>DS</sub> =30V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                          |      |            | 1<br>5      | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current                          | V <sub>DS</sub> =0V, V <sub>GS</sub> = ±20V  |      |            | ±100        | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                             | V <sub>DS</sub> =V <sub>GS</sub> I <sub>D</sub> =250μA                                     | 1.5  | 1.95       | 2.5         | V     |
| I <sub>D(ON)</sub>          | On state drain current                             | V <sub>GS</sub> =10V, V <sub>DS</sub> =5V  | 125  |            |             | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance                  | V <sub>GS</sub> =10V, I <sub>D</sub> =20A<br>TO252<br>T <sub>J</sub> =125°C                |      | 6.2<br>9.5 | 7.5<br>11.5 | mΩ    |
|                             |  | V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A<br>TO252  |      | 8.5        | 11          |       |
|                             |  | V <sub>GS</sub> =10V, I <sub>D</sub> =20A<br>TO251A  |      | 6.7        | 8           | mΩ    |
|                             |  | V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A<br>TO251A                                       |      | 9          | 11.5        | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance                           | V <sub>DS</sub> =5V, I <sub>D</sub> =20A   |      | 63         |             | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                              | I <sub>S</sub> =1A, V <sub>GS</sub> =0V  |      | 0.72       | 1           | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current <sup>G</sup> |  |      |            | 36          | A     |
| <b>DYNAMIC PARAMETERS</b>   |  |  |      |            |             |       |
| C <sub>iss</sub>            | Input Capacitance                                  | V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz  | 920  | 1150       | 1380        | pF    |
| C <sub>oss</sub>            | Output Capacitance                                 |  | 125  | 180        | 235         | pF    |
| C <sub>riss</sub>           | Reverse Transfer Capacitance                       |  | 60   | 105        | 150         | pF    |
| R <sub>g</sub>              | Gate resistance                                    | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz   | 0.55 | 1.1        | 1.65        | Ω     |
| <b>SWITCHING PARAMETERS</b> |  |  |      |            |             |       |
| Q <sub>g(10V)</sub>         | Total Gate Charge                                  | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =20A                            | 16   | 20         | 24          | nC    |
| Q <sub>g(4.5V)</sub>        | Total Gate Charge                                  |  | 7.6  | 9.5        | 11          |       |
| Q <sub>gs</sub>             | Gate Source Charge                                 |  |      | 2.7        |             | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                                  |  |      | 5          |             | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                                  | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =0.75Ω,<br>R <sub>GEN</sub> =3Ω |      | 6.5        |             | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                                  |  |      | 2          |             | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                                 |  |      | 17         |             | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                                 |  |      | 3.5        |             | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time                   | I <sub>F</sub> =20A, di/dt=500A/μs   | 7    | 8.7        | 10.5        | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge                 | I <sub>F</sub> =20A, di/dt=500A/μs   | 11   | 13.5       | 16          | nC    |

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1ir<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>κ</sub> =25°C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=175°C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub> =25°C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <30μs pulses, duty cycle 0.5% max.

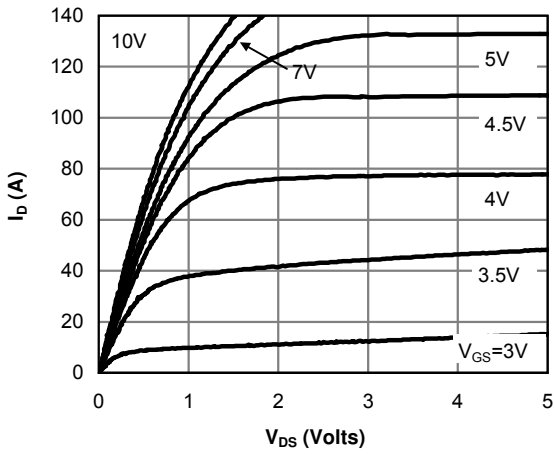
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=175°C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

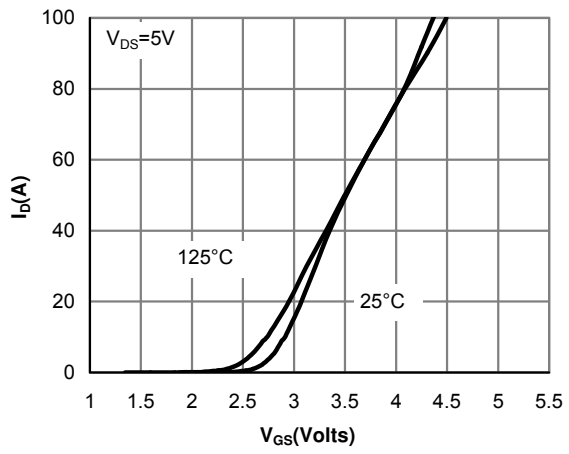
H. These tests are performed with the device mounted on 1 ir<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>κ</sub>=25°C.

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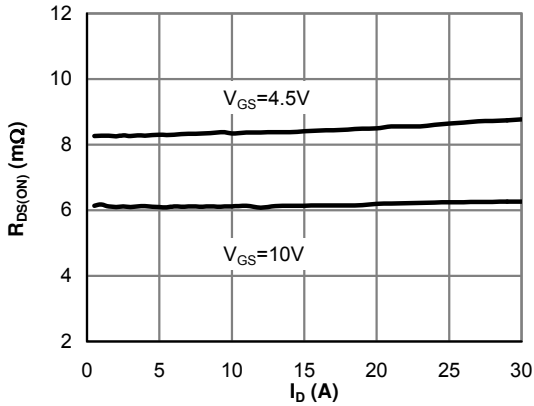
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



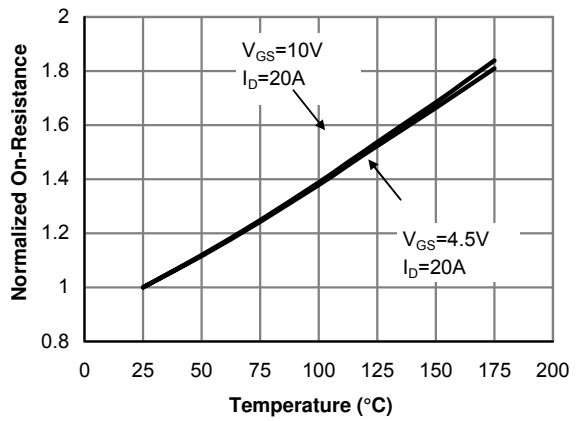
**Fig 1: On-Region Characteristics (Note E)**



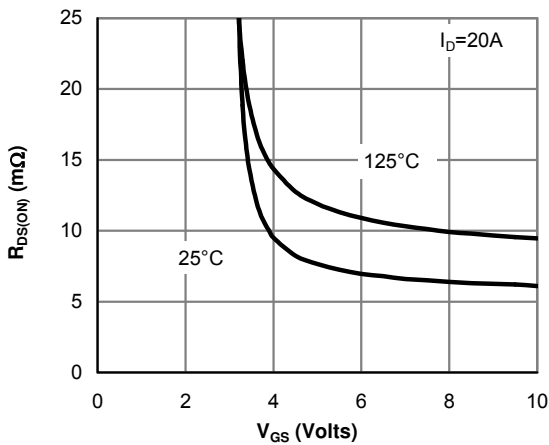
**Figure 2: Transfer Characteristics (Note E)**



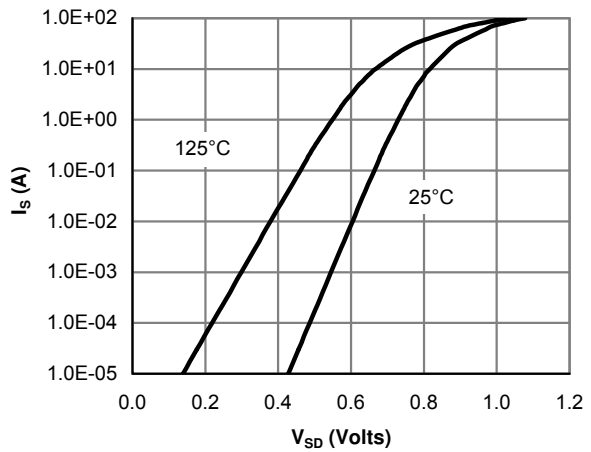
**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**



**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

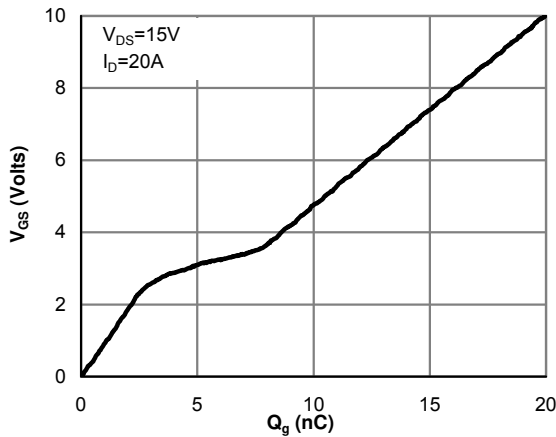


**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

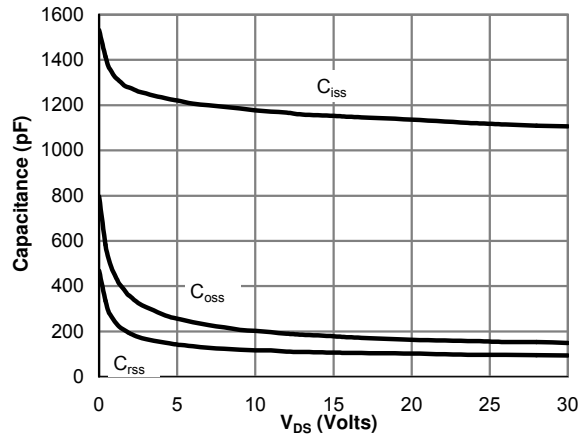


**Figure 6: Body-Diode Characteristics (Note E)**

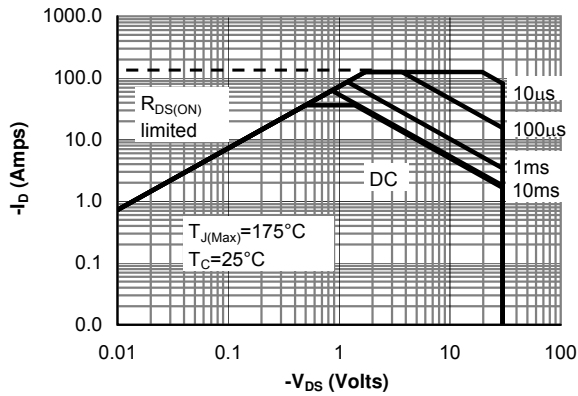
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



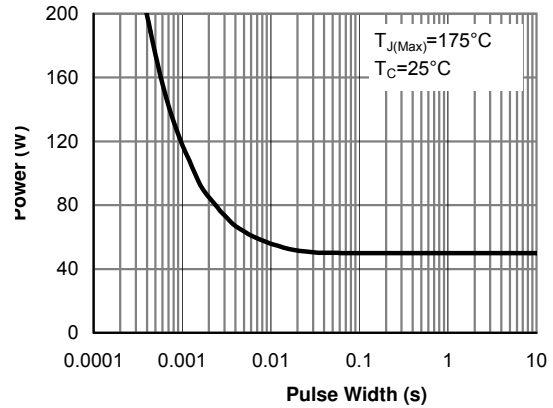
**Figure 7: Gate-Charge Characteristics**



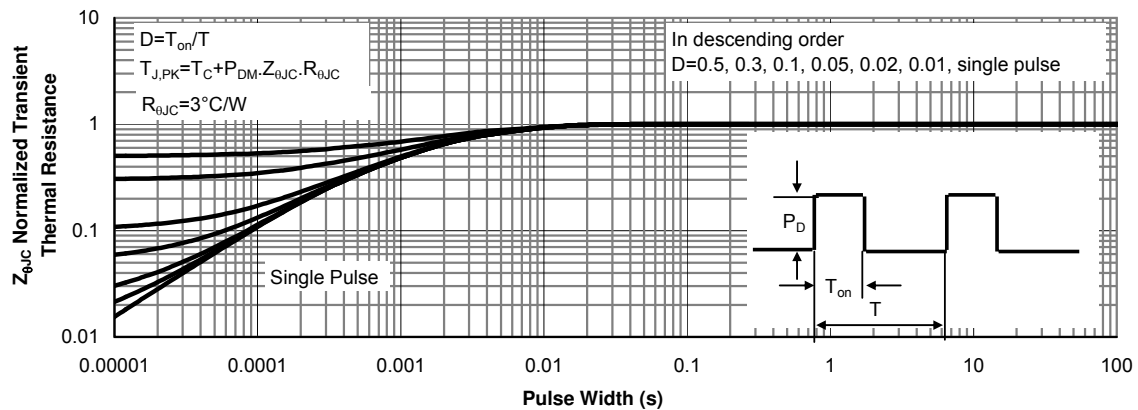
**Figure 8: Capacitance Characteristics**



**Figure 9: Maximum Forward Biased Safe Operating Area (Note F)**

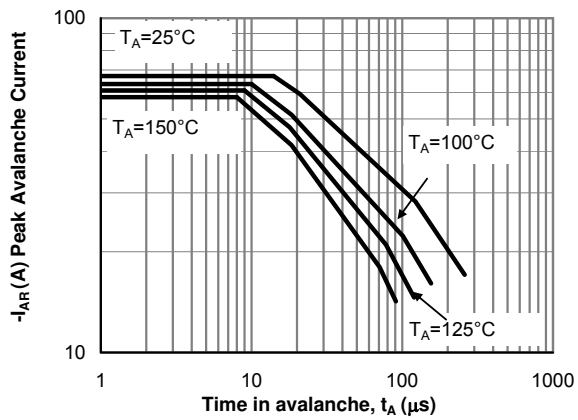


**Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)**

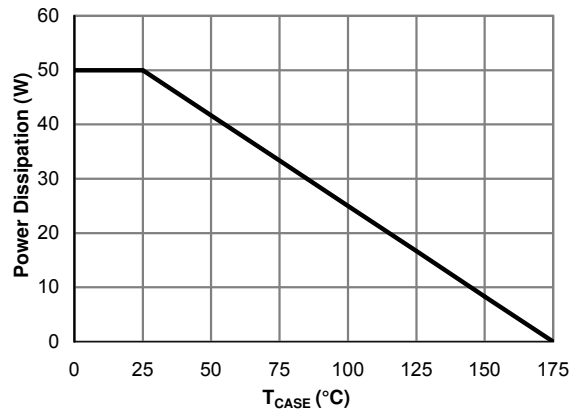


**Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)**

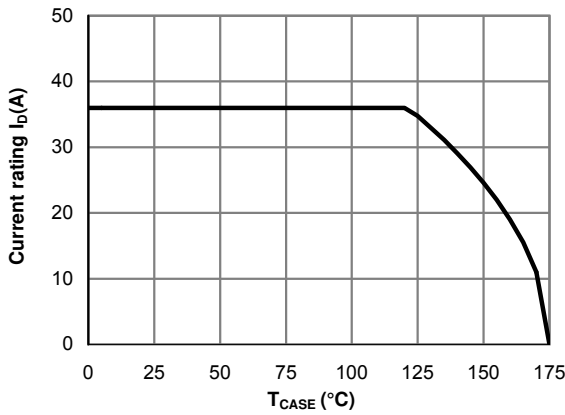
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



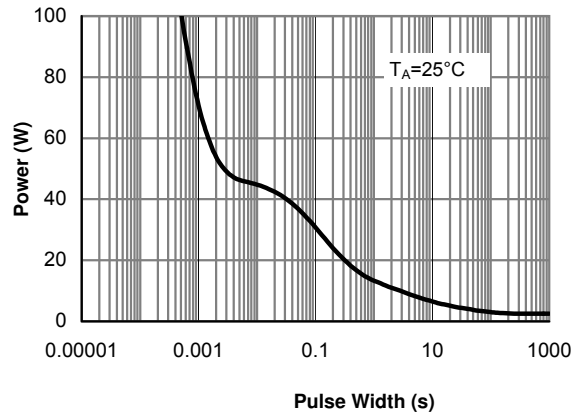
**Figure 12: Single Pulse Avalanche capability (Note C)**



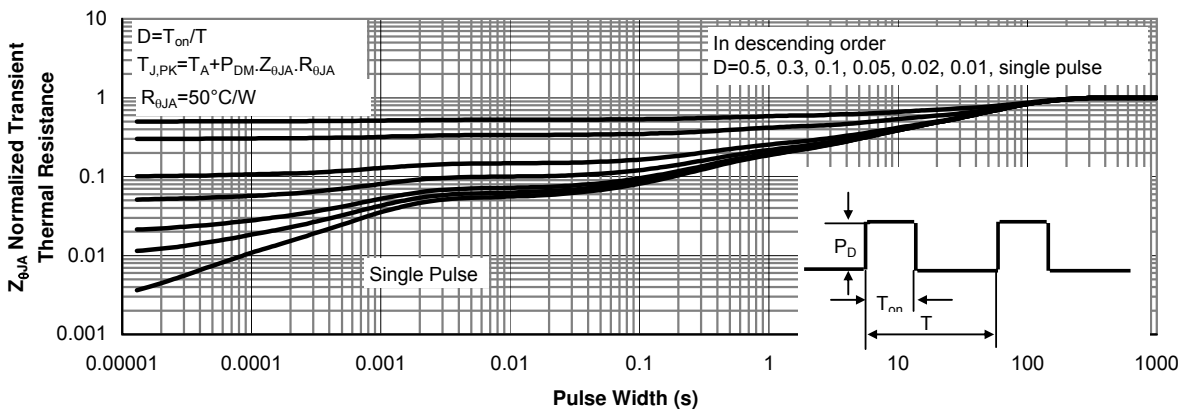
**Figure 13: Power De-rating (Note F)**



**Figure 14: Current De-rating (Note F)**

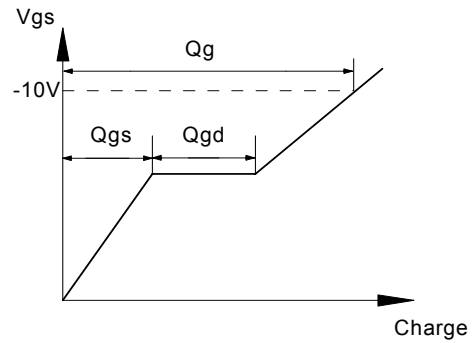
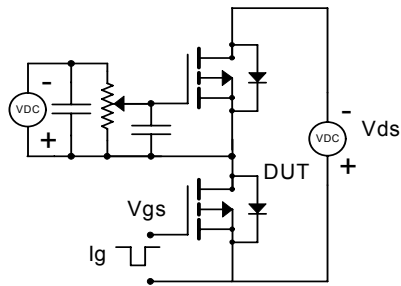


**Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)**

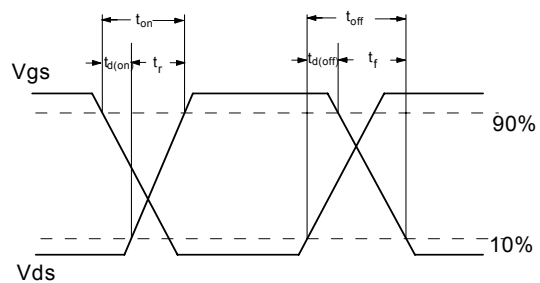
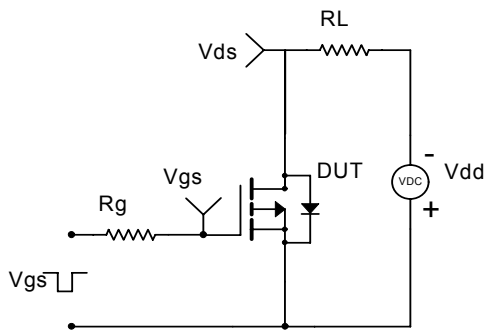


**Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)**

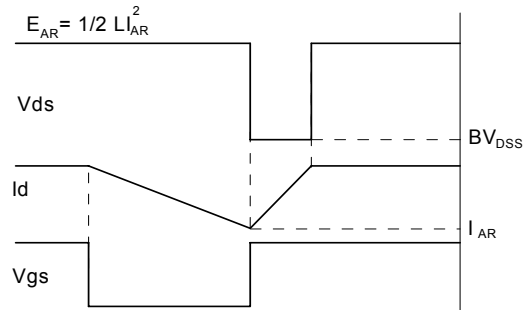
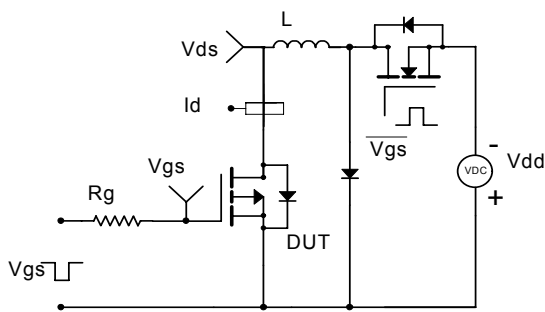
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

